

Notice of References Cited	Application/Control No. 10/615,404	Applicant(s)/Patent Under Reexamination ONOE ET AL.	
	Examiner TAN X. DINH	Art Unit 2653	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-6,510,130 B2	01-2003	Hayashi et al.	369/275.3
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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